Japan Specified Radio Test Report

Report No.	:	**1812C60338912501**
Applicant	:	**Beijing Silion Technology Corp.,Ltd.**
Address	:	**Room 11, 6th Floor, Building 1, No. 9 Shangdi East Road, Haidian District, Beijing, China**
Product Name	:	**RFID module**
Report Date	:	**2026-07-02**

Shenzhen Anbotek Compliance Laboratory Limited

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TEST REPORT

Applicant	:	Beijing Silion Technology Corp.,Ltd.
Manufacturer	:	Beijing Silion Technology Corp.,Ltd.
Product Name	:	RFID module
Model No.	:	SIM3200
Trade Mark	:	N/A
Rating(s)	:	Input: 5V⎓ 2A
Test Standard(s)	:	**MIC Notice No.88 Appendix No.22 Article 2, paragraph 1, item 8**

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the MIC Notice No.88 Appendix No.22 and article 2, paragraph 1, item 8 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt 2026-06-17

Date of Test 2026-06-17 to 2026-06-30

Prepared By Lene Chen

(Lene Chen)

Approved & Authorized Signer Jules Guo

(Jules Guo)

Revision History

Report Version	Description	Issued Date
R00	Original Issue.	2026-07-02

1. General Information

1.1. Client Information

Applicant	:	Beijing Silion Technology Corp.,Ltd.
Address	:	Room 11, 6th Floor, Building 1, No. 9 Shangdi East Road, Haidian District, Beijing, China
Manufacturer	:	Beijing Silion Technology Corp.,Ltd.
Address	:	Room 11, 6th Floor, Building 1, No. 9 Shangdi East Road, Haidian District, Beijing, China
Factory	:	Beijing Silion Technology Corp.,Ltd.
Address	:	Room 11, 6th Floor, Building 1, No. 9 Shangdi East Road, Haidian District, Beijing, China

1.2. Description of Device (EUT)

Product Name	:	RFID module
Model No.	:	SIM3200
Trade Mark	:	N/A
Test Power Supply	:	DC 5V
Test Sample No.	:	1-2-1(Normal Sample), 1-2-2(Engineering Sample)
Hardware Version	:	SIM7200_REV2.0
Software Version	:	24 11 22 19
Adapter	:	N/A
RF Specification		
Support Technology	:	☒ RFID
Support Bandwidth	:	☒ 200kHz ☐ 400kHz ☐ 600kHz ☐ 800kHz ☐ 1000kHz
Operation Frequency	:	916.8MHz to 923.4MHz
Number of Channel	:	19 Channels
Modulation Type	:	ASK
Antenna Type	:	PCB Antenna
Antenna Gain(Peak)	:	3.00dBi
Rated output Power	:	250mW

Remark: (1) All of the RF specification are provided by customer.
(2) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.
(3) All antenna ports are from the same RF feed point, cannot transmit simultaneously.

1.3. Auxiliary Equipment Used During Test

Title	Manufacturer	Model No.	Serial No.
/	/	/	/

1.4. Description of Test Configuration

The EUT has been tested under typical operating condition. The Applicant provides software to control the EUT for staying in continuous transmitting and receiving mode for testing.

Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)
1	**916.8**	5	920.6	9	921.4	13	922.2	17	923.0
2	918.0	6	920.8	**10**	**921.6**	14	922.4	18	923.2
3	919.2	7	921.0	11	921.8	15	922.6	**19**	**923.4**
4	920.4	8	921.2	12	922.0	16	922.8	/	/

Note: EUT was tested with channel 1, 10 and 19.

1.5. Test Conditions

	Normal Test Conditions	Test Conditions
Temperature	15°C - 35°C	24.3°C
Relative Humidity	45% - 75%	61%
Pressure Range	86-106kPa	101kPa

1.6. Test Voltage

Voltage Fluctuation Test	Normal Voltage	High Voltage +10% of Normal Voltage	Low Voltage -10% of Normal Voltage
Input To RF Module	DC 5V	DC 5.5V	DC 4.5V
Output To RF IC Chip	DC 3.30V	DC 3.30V	DC 3.30V
Voltage Variation (%)	--	--	--

Note: Voltage Variation (%)=(Output high or Low Voltage - Output Normal Voltage)/ Output Normal Voltage* 100

For extreme voltage test, we have tested the relationship between the external power supply and RF IC power supply. Base on the test results, only the normal voltage was selected to perform all items.

1.7. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Last Cal.	Cal.Due Date
1	Spectrum Analyzer	Rohde & Schwarz	FSV40-N	2025-12-29	2026-12-28
2	MXA Spectrum Analysis	KEYSIGHT	N9020A	2025-12-29	2026-12-28
3	MXG RF Vector Signal Generator	Agilent	N5182A	2025-12-29	2026-12-28
Note: The above test equipment is calibrated by Guangzhou LiSai Metrology & Test Co.,Ltd. Calibration method reference Article 24-2, Paragraph 4 of the Radio Act. (method c)					
4	Constant Temperature Humidity Chamber	ZHONGJIAN	ZJ-HWHS80B	2025-08-29	2026-08-28
Note: The test equipment is calibrated by GUANGZHOU NEM METROLOGY&TEST TECHNOLOGY CO.,LTD Calibration method reference Article 24-2, Paragraph 4 of the Radio Act. (method c)					
5	DC Power Supply	IVYTECH	IV3605	2025-09-05	2026-09-04
Note: The test equipment is calibrated by Centre Testing International Group Co., Ltd. (CTI) Calibration method reference Article 24-2, Paragraph 4 of the Radio Act. (method c)					
6	Oscilloscope	Tektronix	MDO3012	2025-09-30	2026-09-29
Note: The test equipment is calibrated by Ti Testing & Certification Group Co., Ltd. Shenzhen Branch Calibration method reference Article 24-2, Paragraph 4 of the Radio Act. (method c)					
Remark: (a) Callbration conducted by the National institute of infommation and Communications Technology (NiCT)in Japan (hereinafter referred to as "NICT") or a designated calbration agency under Article 102-18paragraph (1) in JRL. (b) Correction conducted pursuant to the provisions of Article 135 or Article 144 of the Measurement Act(Act No. 51 of 1992). (c) Calilbration conducted in countries except Japan, which shall be equivalent to the calibration conductedby the NiCT or a designated calibration agency under Article 102-18 paragraph (1). (d) Calibration, etc, conducted by using measuring instruments and other equipment listed in the rightcolumn of appended table No. 3, which shall have been given any type of calbration, etc. listed abovefrom (a)1o (c) From JRL Article 24 .2, paragraph 4, Item 2					

1.8. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 279531

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 279531.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.
Sogood Industrial Zone Laboratory & 1/F. of Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Subdistrict, Bao'an District, Shenzhen, Guangdong, China.

1.9. Disclaimer

1. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
2. The test report is invalid if there is any evidence and/or falsification.
3. The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
4. This document may not be altered or revised in any way unless done so by Anbotek and all revisions are duly noted in the revisions section.
5. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
6. The authenticity of the information provided by the customer is the responsibility of the customer and the laboratory is not responsible for its authenticity.
7. The data in this report will be synchronized with the corresponding national market supervision and management departments and cross-border e-commerce platforms as required by regulatory agencies.

The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

1.10. Measurement Uncertainty

Parameter	Uncertainty
Occupied Bandwidth	552Hz
Conducted Output Power	0.84dB
Conducted Spurious Emission	1.24dB
Frequency tolerance	58Hz
Adjacent Channel Leakage Power	1.85dB
The measurement uncertainty and decision risk evaluated according to AB/WI-RF-F-032. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.	

2. Summary of Test Results

Test Standard	Description of Test	Result
MIC Notice No.88 Appendix No.22 Article 2 Paragraph 1 Item 8	Frequency Tolerance	Complies
	Antenna power	Complies
	EIRP	Complies
	Antenna Power Tolerance	Complies
	Occupied Bandwidth	Complies
	Spread Bandwidth	Complies
	Adjacent Channel Leakage Power	Complies
	Transmission Time Restriction	Complies
	Unwanted Emission Strength	Complies
	Carrier sensing function	Complies
	Interference prevention function	Complies
	Secondary Radiated Emission Strength	Complies

Note:

(1) N/A is an abbreviation for Not Applicable.

3. Frequency Tolerance Test

3.1. Test Limit

Test Limit	±20 ppm (However, those using "one unit channel" can be designated as specified frequency band*) *Cf : 916.0~928.0MHz(200kHz step) : within 200kHz BW

3.2. est Setup

3.3. Test Procedure

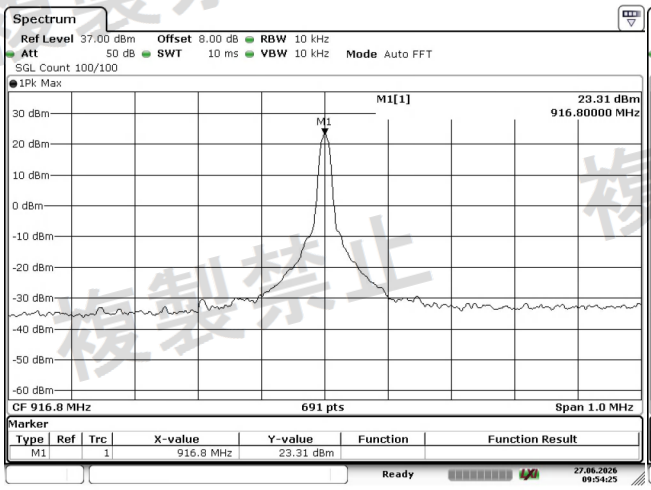
Test Frequency= test channel
RBW=VBW=10kHz
Span=1MHz
Sweep time=Auto
Detector mode=Positive peak
Indication mode=Max hold

3.4. Test Data

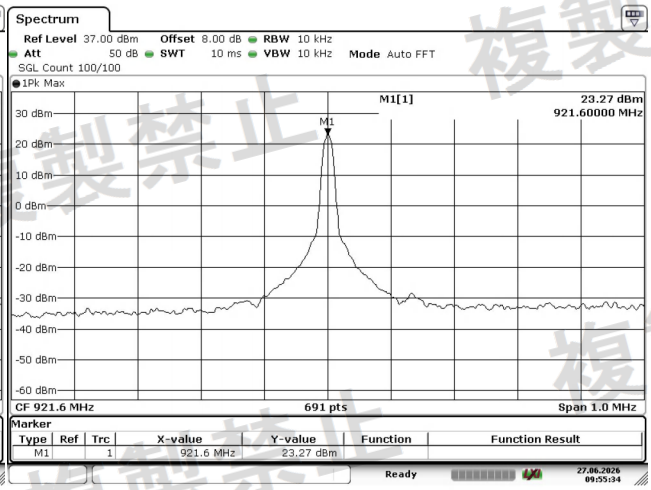
Pass

Test Condition	Frequency (MHz)	Reading(MHz)	Tolerance (ppm)	Limit (ppm)
NTNV	916.80	916.80000	0.0000	±20
NTNV	921.60	921.60000	0.0000	±20
NTNV	923.40	923.40000	0.0000	±20

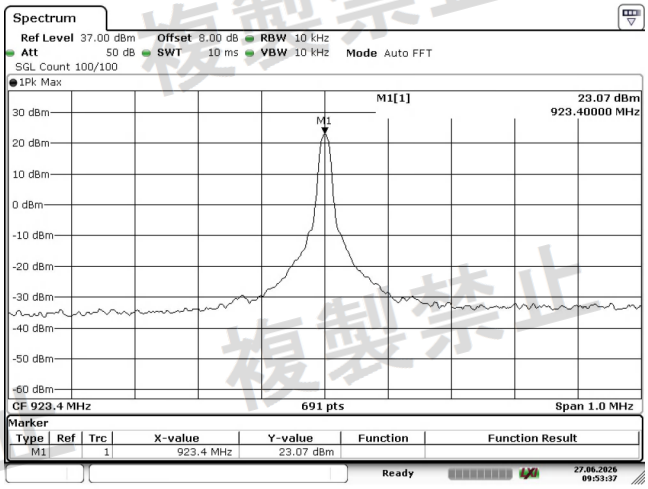
Note:
Result[ppm]= (Center Freq[MHz] -Freq.[MHz])/Freq.[MHz]*1000000



Low Channel



Middle Channel



High Channel

4. Antenna Power Test

4.1. Test Limit

Test Limit	
Antenna Power	0.25W or less (0.5W or less: When the radio equipment shall be housed in a single cabinet, and the cabinet shall not be capable of being opened easily &an EIRP is less than a 27dBm.)
EIRP	27dBm or less
Tolerance	+20%,-80%

4.2. Test Setup

4.3. Test Configuration

RBW=VBW=1MHz
Span=Wide enough to cover the complete power envelope of the signal of the EUT.
Sweep time=Auto
Detector mode =Positive peak
Indication mode=Max hold

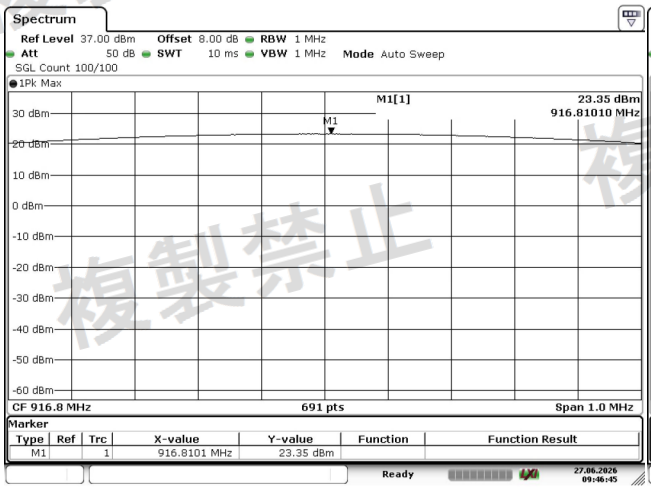
4.4. Test Data

Pass

Antenna port 2:

Antenna Power				EIRP=Power+antenna gain	
				Antenna gain=3dBi	
Test Channel	Power(dBm)	Power(mW)	Limit(mW)	EIRP(dBm)	Limit(dBm)
Low CH	23.35	216.272	250	26.35	27
Mid CH	23.29	213.304	250	26.29	27
High CH	23.21	209.411	250	26.21	27

Tolerance				
Test Channel	Power(mW)	Rated Power(mW)	Result (%)	Limit (%)
Low CH	216.272	250	-13.49%	-80 to +20
Mid CH	213.304	250	-14.68%	-80 to +20
High CH	209.411	250	-16.24%	-80 to +20



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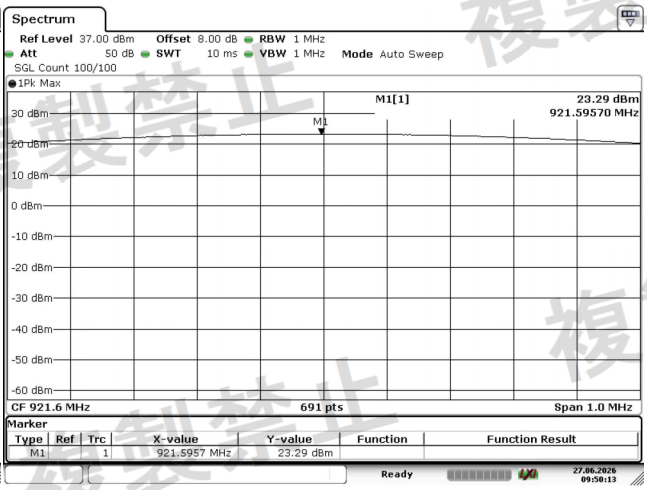
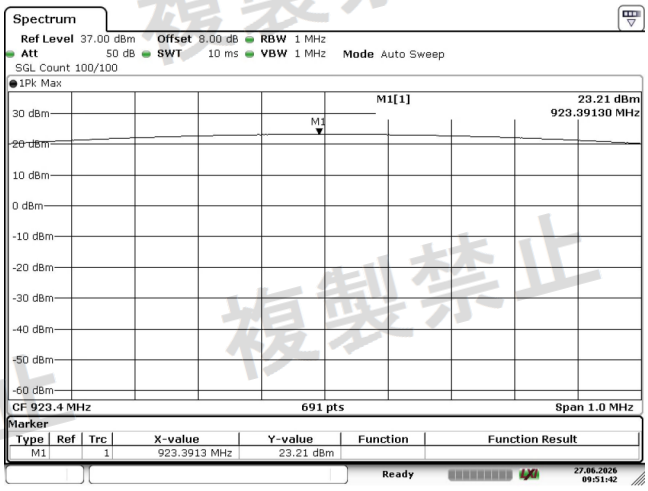


Middle Channel

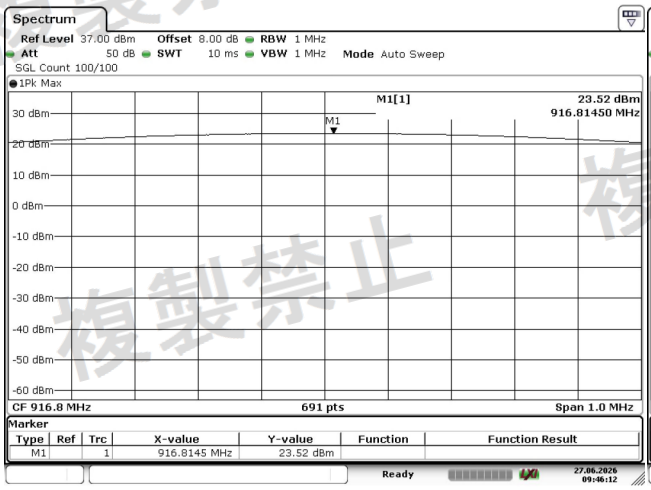


High Channel

Antenna port 2:

Antenna Power				EIRP=Power+antenna gain	
				Antenna gain=3dBi	
Test Channel	Power (dBm)	Power (mW)	Limit (mW)	EIRP (dBm)	Limit (dBm)
Low CH	23.52	224.905	250	26.52	27
Mid CH	23.28	212.814	250	26.28	27
High CH	23.18	207.970	250	26.18	27

Tolerance				
Test Channel	Power (mW)	Rated Power (mW)	Result (%)	Limit (%)
Low CH	224.905	250	-10.04%	-80 to +20
Mid CH	212.814	250	-14.87%	-80 to +20
High CH	207.970	250	-16.81%	-80 to +20



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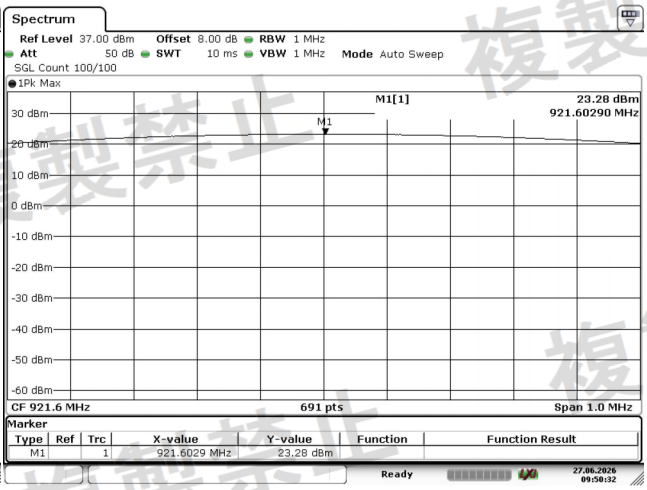

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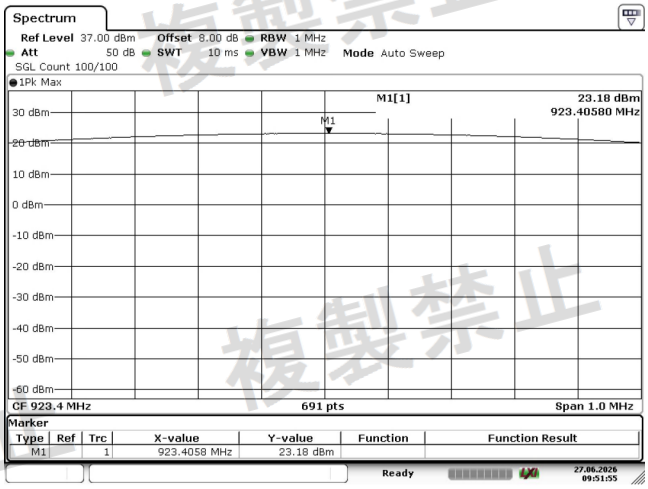
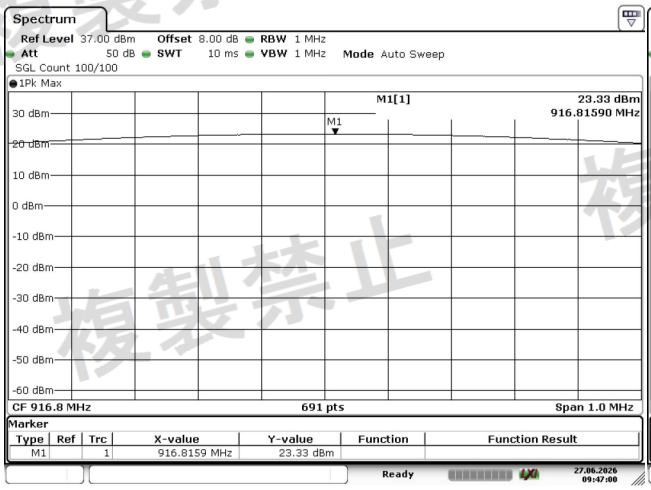


High Channel

Antenna port 3:

Antenna Power				EIRP=Power+antenna gain Antenna gain=3dBi	
Test Channel	Power (dBm)	Power (mW)	Limit (mW)	EIRP (dBm)	Limit (dBm)
Low CH	23.33	215.278	250	26.33	27
Mid CH	23.24	210.863	250	26.24	27
High CH	23.16	207.014	250	26.16	27

Tolerance				
Test Channel	Power (mW)	Rated Power (mW)	Result (%)	Limit (%)
Low CH	215.278	250	-13.89%	-80 to +20
Mid CH	210.863	250	-15.65%	-80 to +20
High CH	207.014	250	-17.19%	-80 to +20



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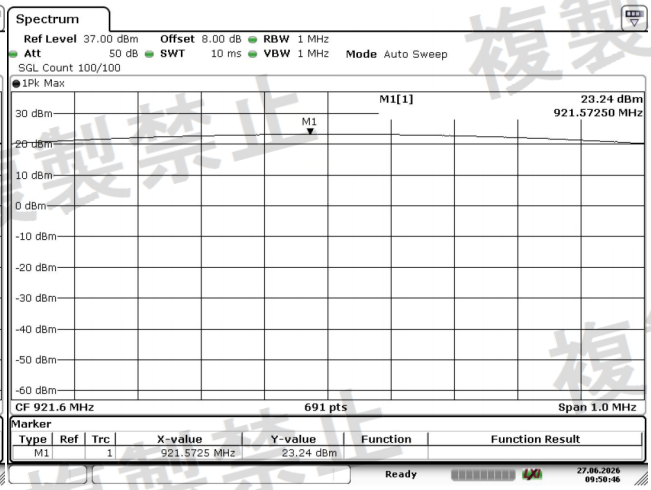

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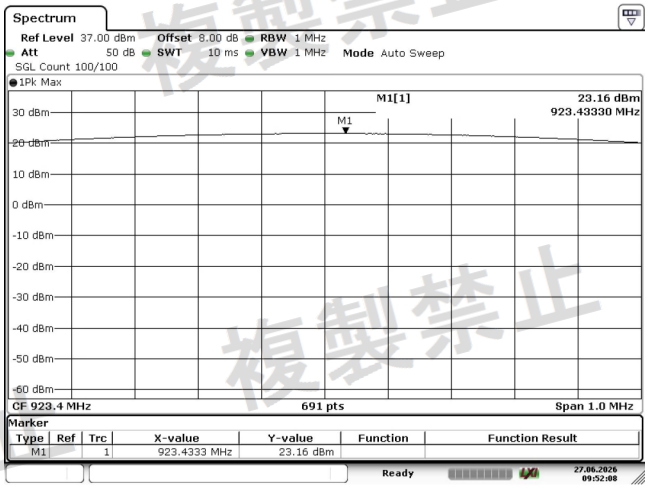
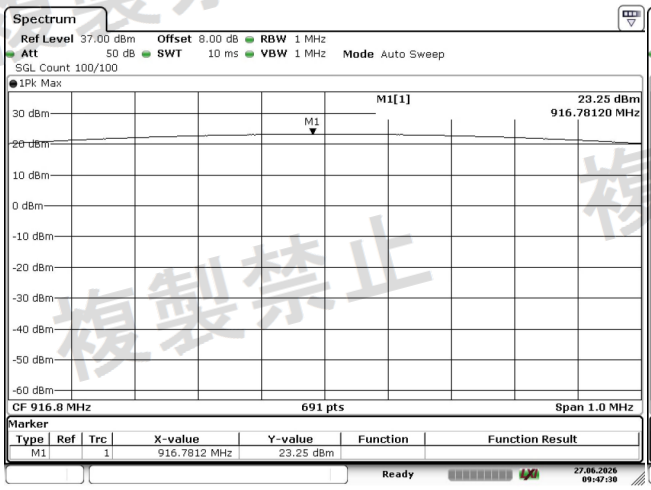


High Channel

Antenna port 4:

Antenna Power				EIRP=Power+antenna gain	
				Antenna gain=3dBi	
Test Channel	Power (dBm)	Power (mW)	Limit (mW)	EIRP (dBm)	Limit (dBm)
Low CH	23.25	211.349	250	26.25	27
Mid CH	23.22	209.894	250	26.22	27
High CH	23.13	205.589	250	26.13	27

Tolerance				
Test Channel	Power (mW)	Rated Power (mW)	Result (%)	Limit (%)
Low CH	211.349	250	-15.46%	-80 to +20
Mid CH	209.894	250	-16.04%	-80 to +20
High CH	205.589	250	-17.76%	-80 to +20



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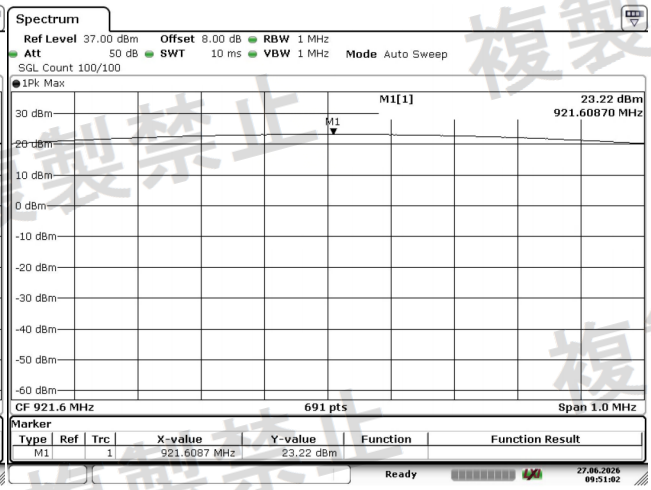

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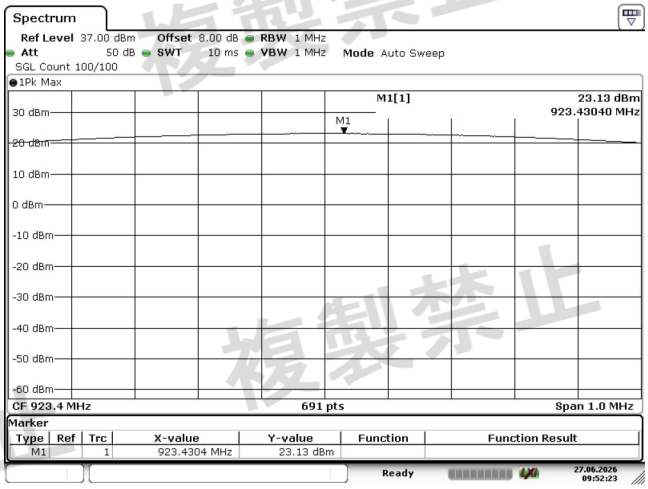


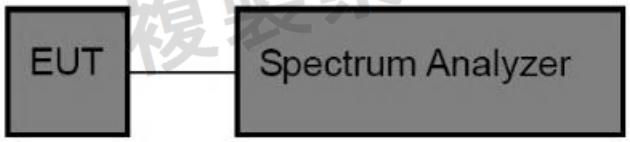
High Channel

5. Occupied Bandwidth (99%) Test

5.1. Test Limit

Type	Simultaneous use channel	Frequency Allocation	OBW
916.7~923.4MHz	n = 1	916.8, 918, 919.2 920.4 ~ 923.4MHz (200kHz interval 16 channels)	200kHz
	n = 2	920.5 ~ 923.3MHz (200kHz interval 15 channels)	400kHz
	n = 3	920.6 ~ 923.2MHz (200kHz interval 14 channels)	600kHz
	n = 4	920.7 ~ 923.1MHz (200kHz interval 13 channels)	800kHz
	n = 5	920.8~ 923.0MHz (200kHz interval 12 channels)	1000kHz

5.2. Test Setup



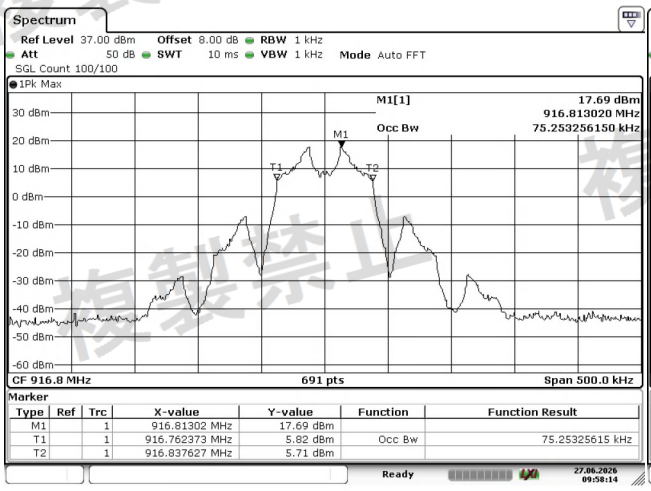
5.3. Test Configuration

Test Frequency= test channel
RBW=VBW=1kHz
Span=500kHz
Sweep time=Auto
Detector mode=Positive peak
Indication mode=Max hold

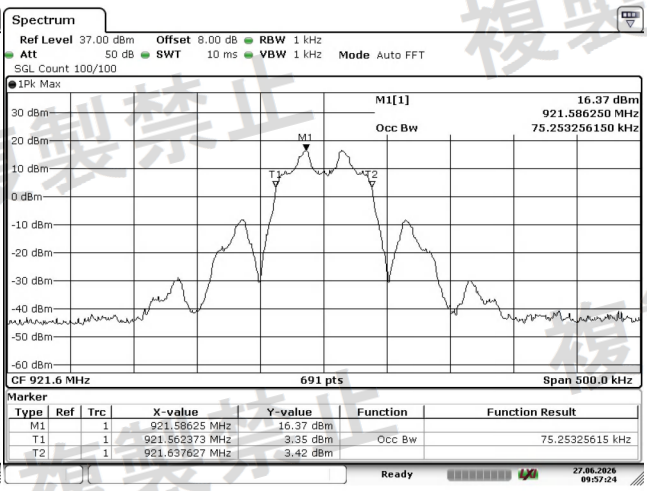
5.4. Test Data

Pass

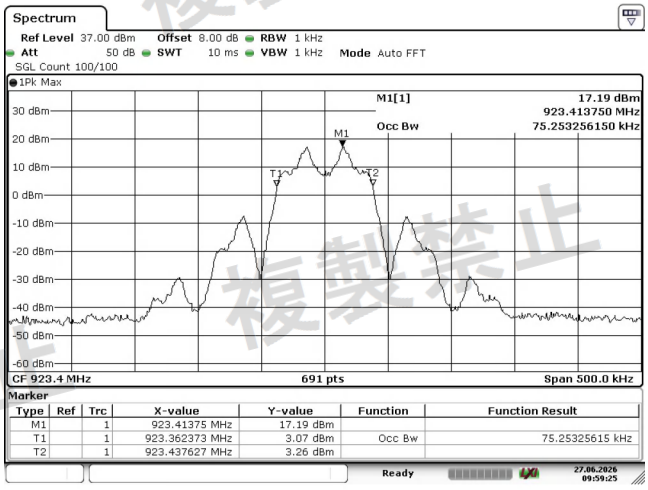
Test Channel	99% Bandwidth(kHz)	Limit(kHz)
Low CH	75.2532	≤200
Middle CH	75.2532	≤200
High CH	75.2532	≤200



Low Channel



Middle Channel



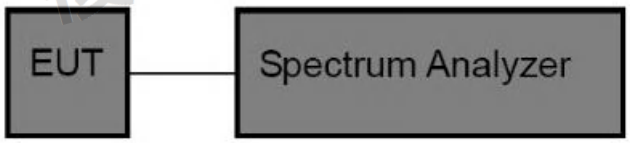
High Channel

6. Adjacent Channel Leakage Power Test

6.1. Test Limit

Adjacent unit channels: -5dBm or less
Radio channel both ends: 4dBm or less

6.2. Test Setup



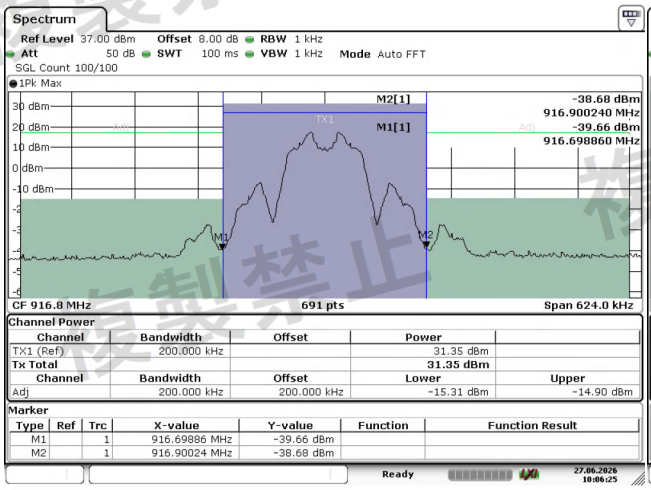
6.3. Test Configuration

RBW=VBW=1kHz
Span=624kHz
Sweep time=Auto
Detector mode =Positive peak
Indication mode=Max hold

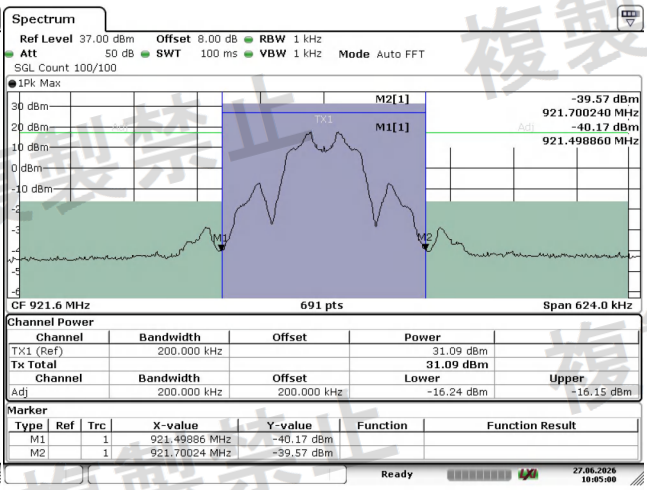
6.4. Test Data

Pass

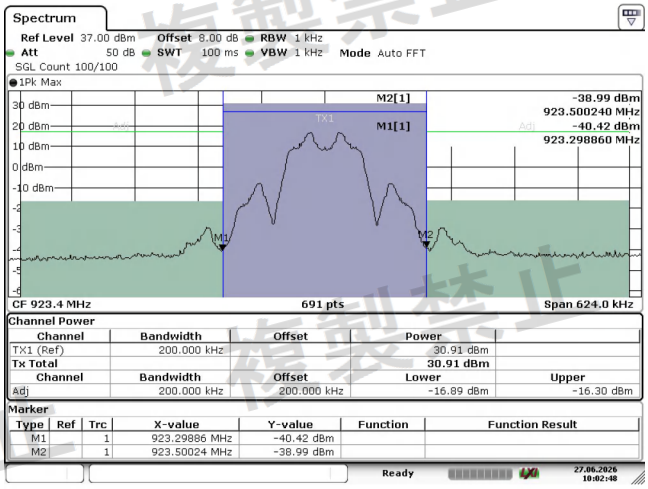
Test Channel	Result
Low	Pass
Middle	Pass
High	Pass



Low Channel



Middle Channel



High Channel

7. Transmission Time Restriction Test

7.1. Test Limit

Test Limit		
Frequency (MHz)	Total transmission time	Transmission Time Restriction
916.7～923.5MHz	N/A	Transmission ON: within 4 sec. Transmission OFF: over 0.05 sec. *When retransmitting within 4sec. after discharging a radio wave first, it can transmit without a suspend time. (It restricts to the retransmission within applicable time by the transmission after performing the career sense for less than 128us or more.)

7.2. Test Setup

7.3. Test Configuration

RBW=VBW=1MHz
Span=0Hz
Sweep time=5s
Detector mode =Positive peak
Indication mode=Max hold

7.4. Test Data

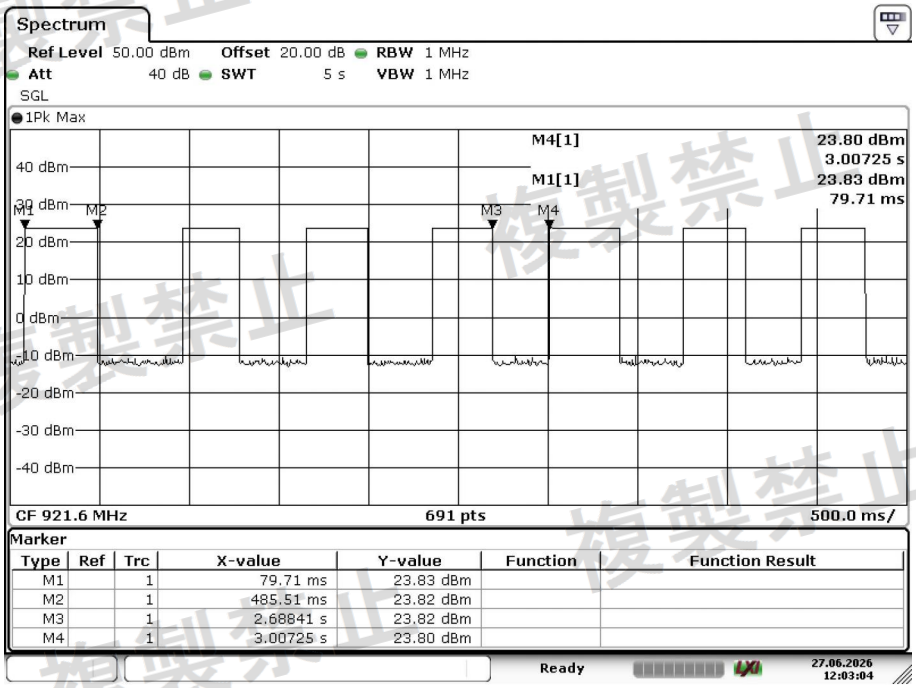
Pass

Please refer to the following data.

Test Channel	Item	Measured burst length (s)	Limit (s)	Result
Mid CH	Ton	0.4058	＜4	Pass
	Toff	0.31884	＞0.05	Pass

Ton=M2-M1=485.51-79.71=405.8ms=0.4058s

Toff=M4-M3=3.00725-2.68841=0.31884s



Mid Channel

8. Unwanted Emission Strength Test

8.1. Limit and Reference Bandwidth

~ (≤) 710MHz : -36dBm/100kHz
710 (<) ~ (≤) 900MHz : -55dBm/1MHz
900 (<) ~ (≤) 915MHz : -55dBm/100kHz
915 (<) ~ (≤) 915.7MHz : -36dBm/100kHz
915.7 (<) ~ (≤) 923.5MHz* : -29dBm/100kHz
923.5 (<) ~ (≤) 930MHz : -36dBm/100kHz
930 (<) ~ (≤) 1000MHz : -55dBm/100kHz
1000 (<) ~ (≤) 1215MHz : -45dBm/1MHz
1215MHz (<) ~ : -30dBm/1MHz
*except " 100 (n + 1) kHz" from Cf

8.2. Test Setup

8.3. Test Configuration

Test Frequency: test channel,
RBW: From 945MHz up to 1GHz and if, 100kHz from 30MHz to 710MHz frequency sweep width
From 1GHz to 10GHz and if, 1MHz from 710MHz to 900MHz frequency sweep width
VBW=RBW
Sweep time=Auto, Detector mode=Positive peak

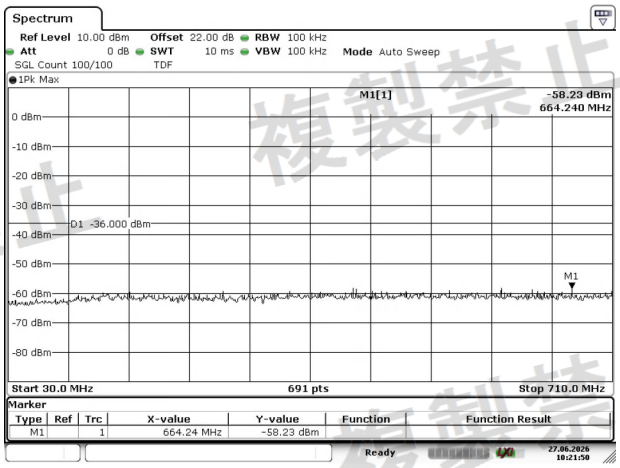
8.4. Test Data

Pass

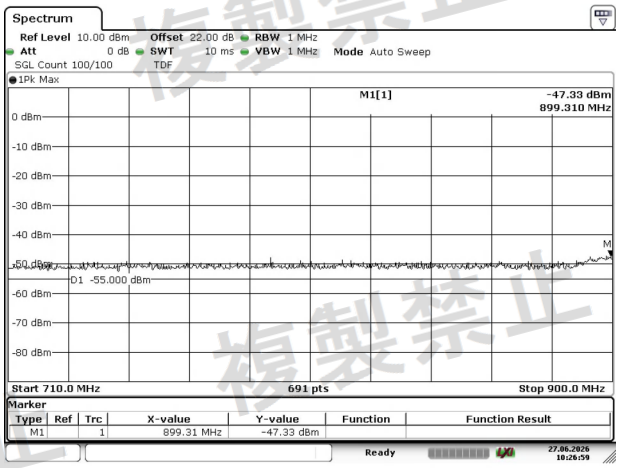
Please refer to the following data.

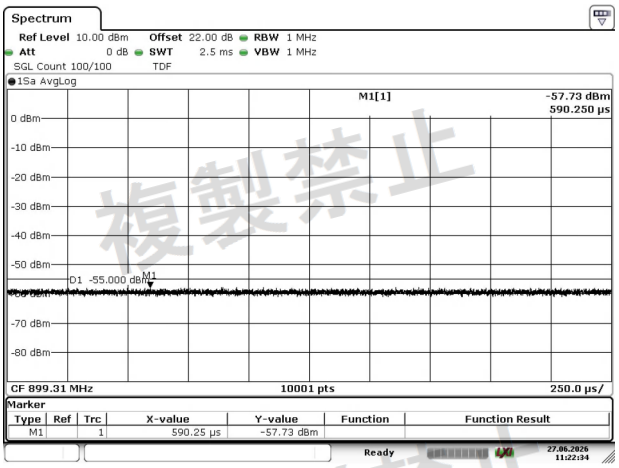
Test Condition	Freq(MHz)	Freq.Range [MHz]	Freq. [MHz]	Result [dBm]	Limit [dBm]	Verdict
NTNV	916.8	30~710	664.24	-58.23	≤-36	PASS
		710~900	899.31	-57.73	≤-55	PASS
		900~915	914.75	-67.64	≤-55	PASS
		915-915.7	915.196	-51.19	≤-36	PASS
		915.7-916.6	916.0992	-57.62	≤-29	PASS
		917-923.5	923.4012	-51.57	≤-29	PASS
		923.5-930	929.9577	-57.96	≤-36	PASS
		930-1000	998.43	-59.73	≤-55	PASS
		1000-12150	6204	-53.22	≤-45	PASS
		12200-25000	16896	-50.61	≤-30	PASS
	921.6	30~710	355.24	-58.44	≤-36	PASS
		710~900	899.59	-57.24	≤-55	PASS
		900~915	912.015	-59.71	≤-55	PASS
		915-915.7	915.1646	-50.85	≤-36	PASS
		915.7-921.4	916.0011	-57.17	≤-29	PASS
		921.8-923.5	923.6849	-50.92	≤-29	PASS
		923.5-930	929.6849	-58.35	≤-36	PASS
		930-1000	984.55	-59.20	≤-55	PASS
		1000-12150	6091	-52.91	≤-45	PASS
		12200-25000	24750	-50.42	≤-30	PASS
	923.4	30~710	561.9	-58.12	≤-36	PASS
		710~900	894.64	-57.69	≤-55	PASS
		900~915	911.93	-64.21	≤-55	PASS
		915-915.7	915.2021	-50.71	≤-36	PASS
		915.7-923.2	918.039	-56.69	≤-29	PASS
		923.6-930	929.9027	-58.29	≤-36	PASS
		930-1000	940.48	-59.08	≤-55	PASS
		1000-12150	9237	-51.93	≤-45	PASS
		12200-25000	15507	-50.18	≤-30	PASS

Test Plots of Low Channel

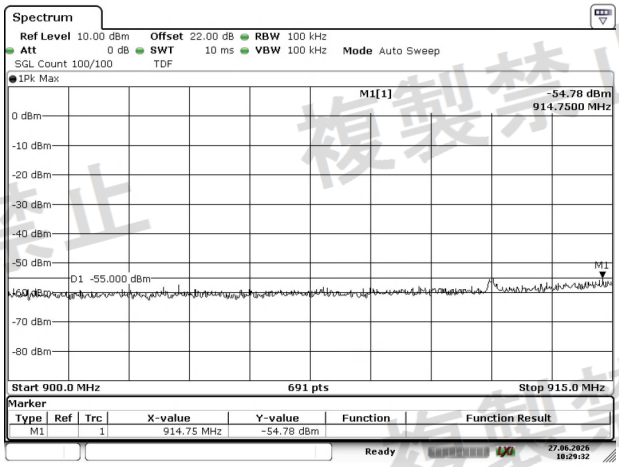


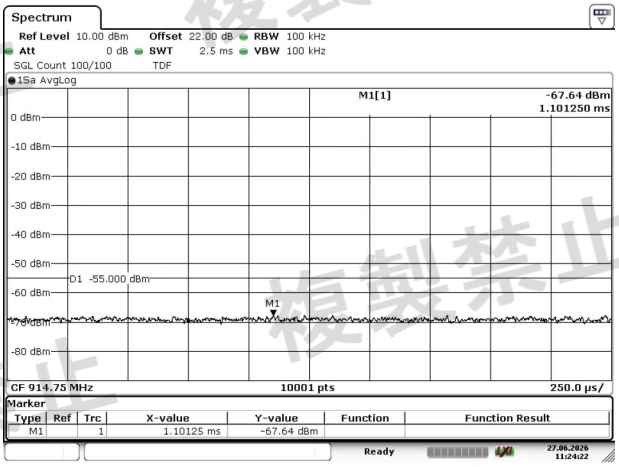
30MHz~710MHz



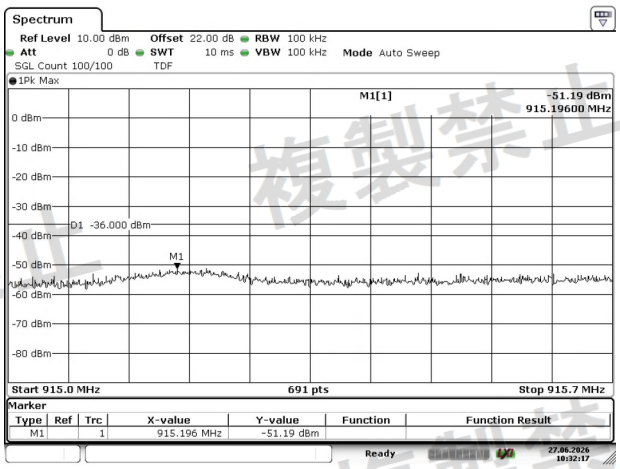


710MHz~900MHz

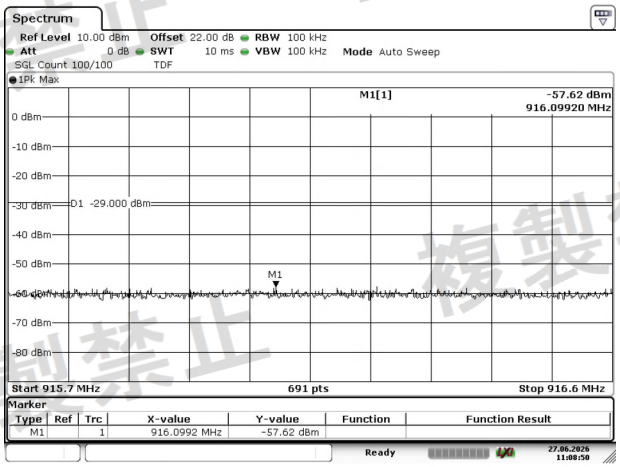




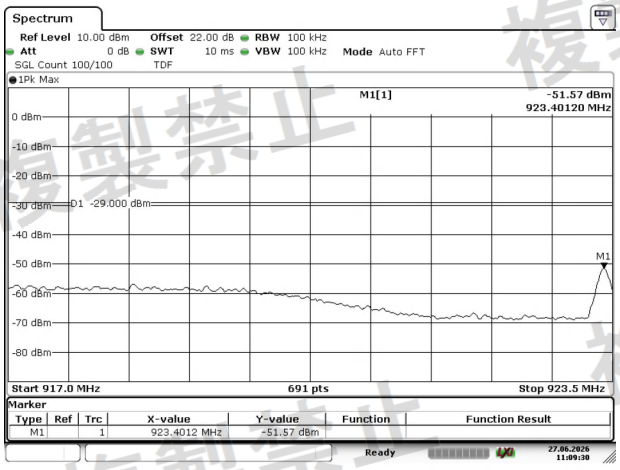
900MHz~915MHz



915MHz~915.7MHz

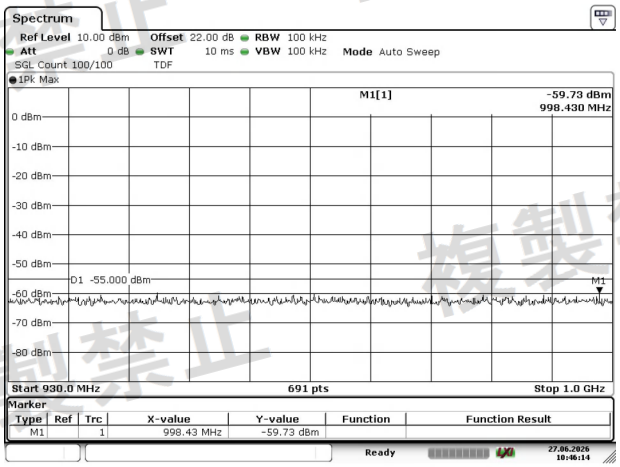


915.7MHz~916.6MHz

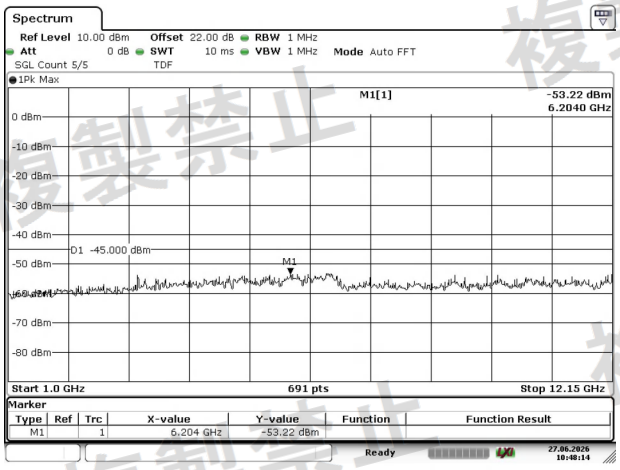


917MHz~923.5MHz

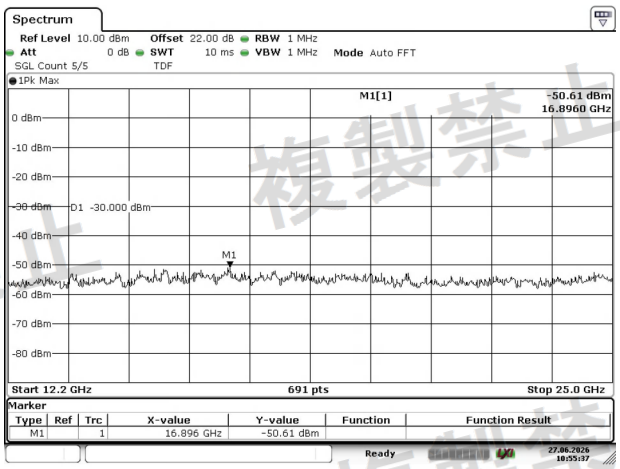
923.5MHz~930MHz



930MHz~1000MHz

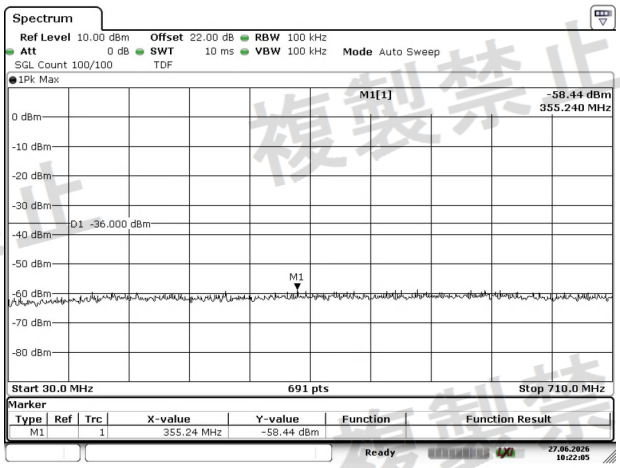


1000MHz~12150MHz

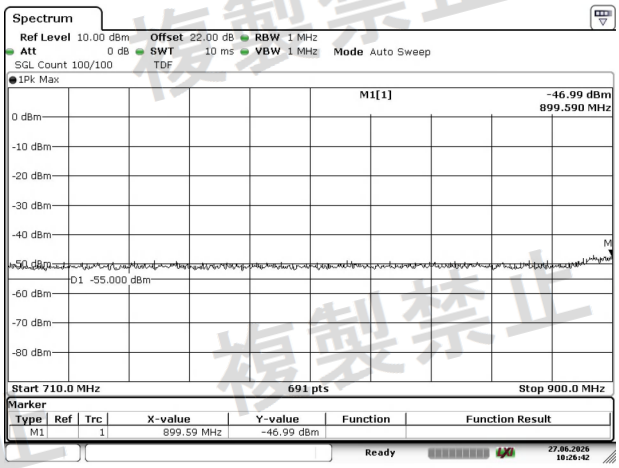


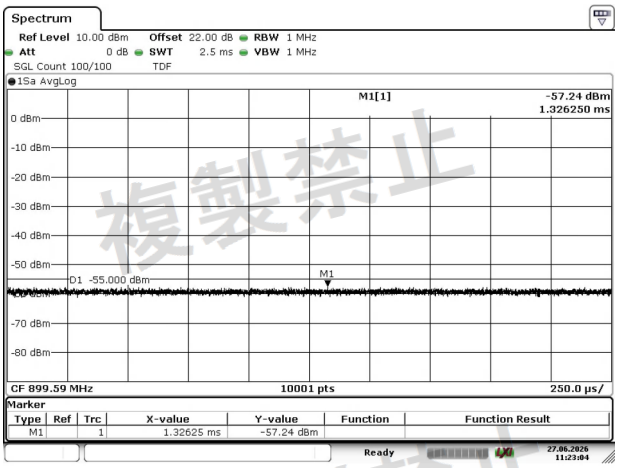
12200MHz~25000MHz

Test Plots of Middle Channel

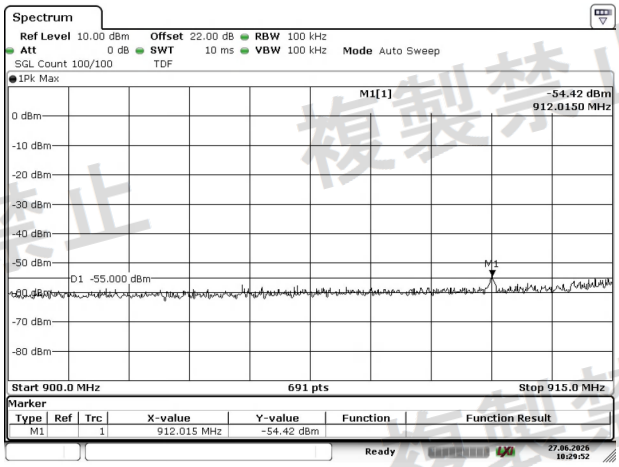


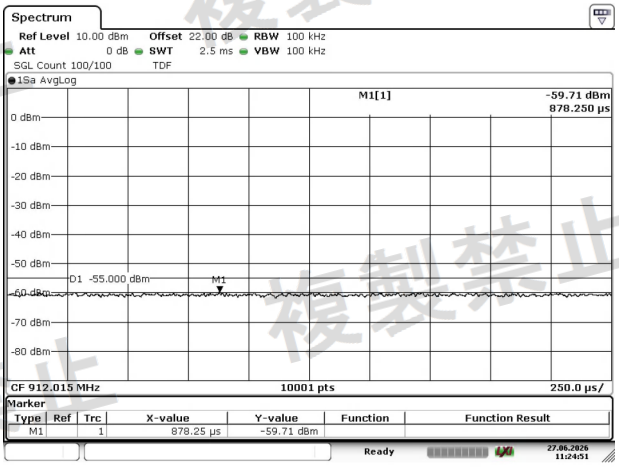
30MHz~710MHz





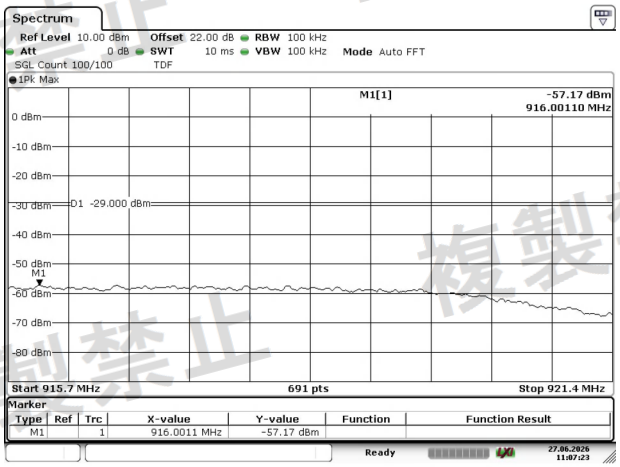
710MHz~900MHz



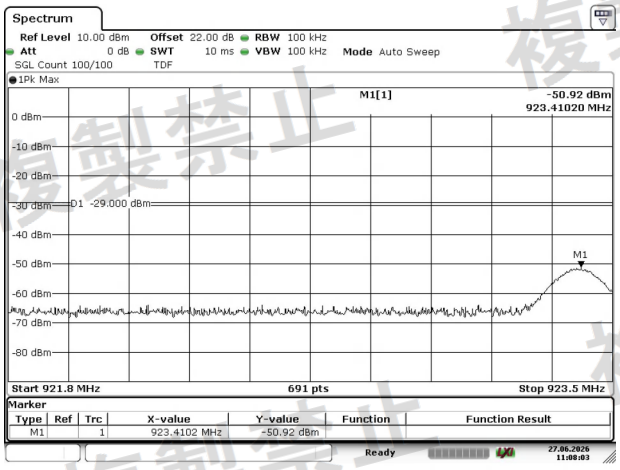


900MHz~915MHz

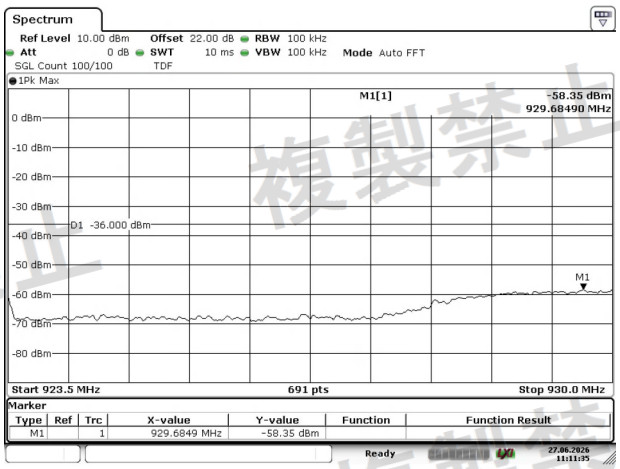
915MHz~915.7MHz



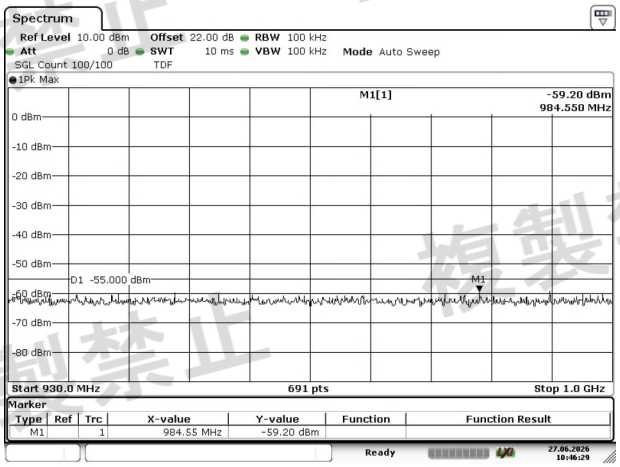
915.7MHz~921.4MHz



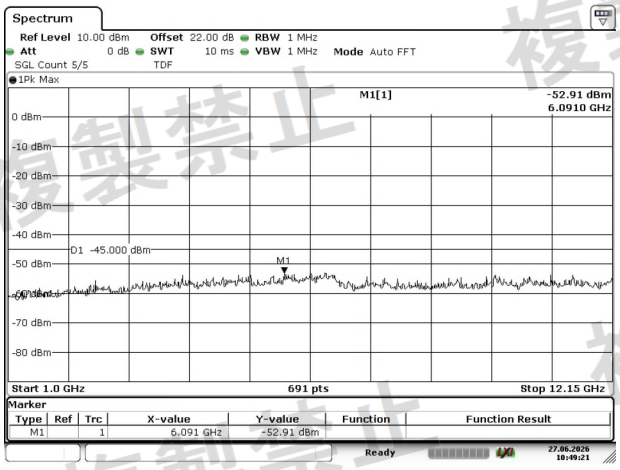
921.8MHz~923.5MHz



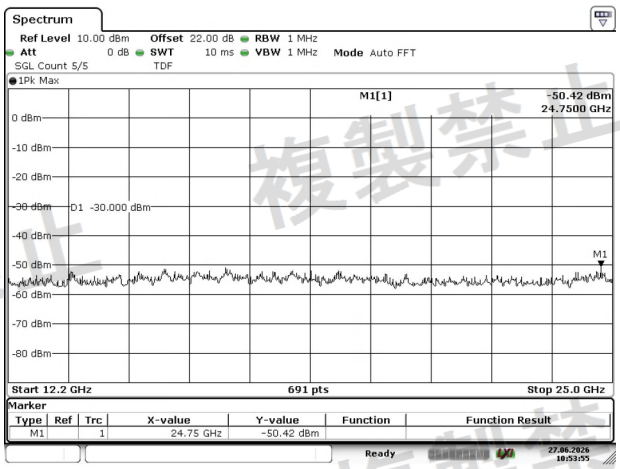
923.5MHz~930MHz



930MHz~1000MHz

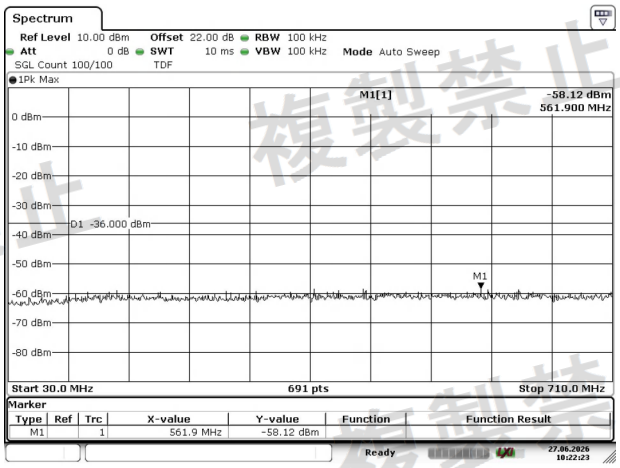


1000MHz~12150MHz

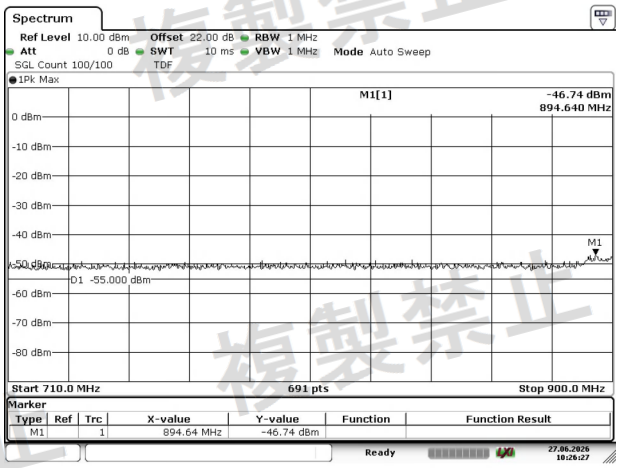


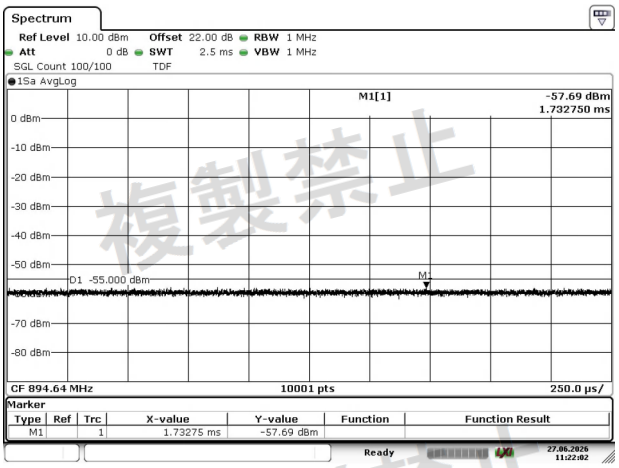
12200MHz~25000MHz

Test Plots of High Channel

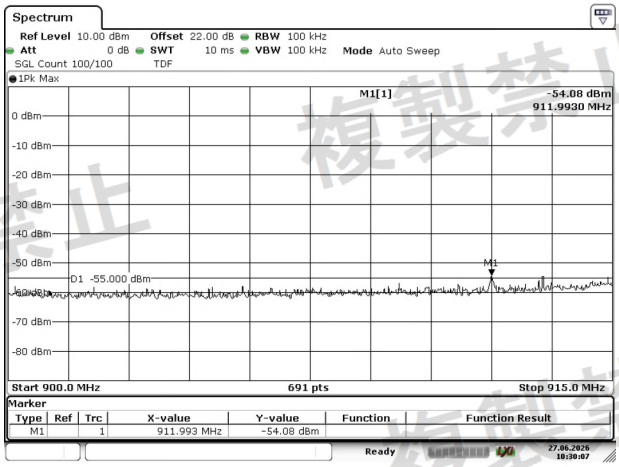


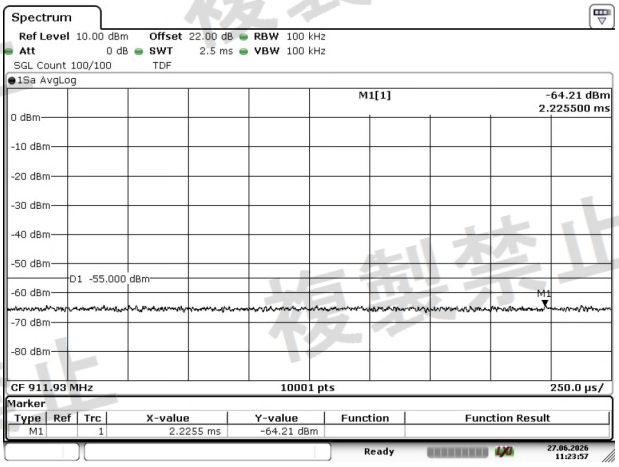
30MHz~710MHz



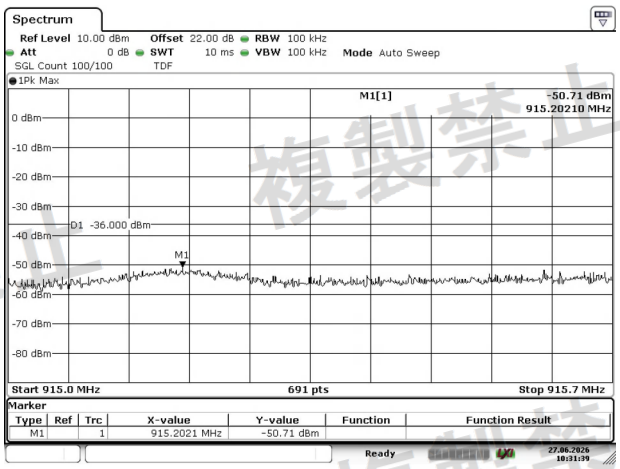


710MHz~900MHz

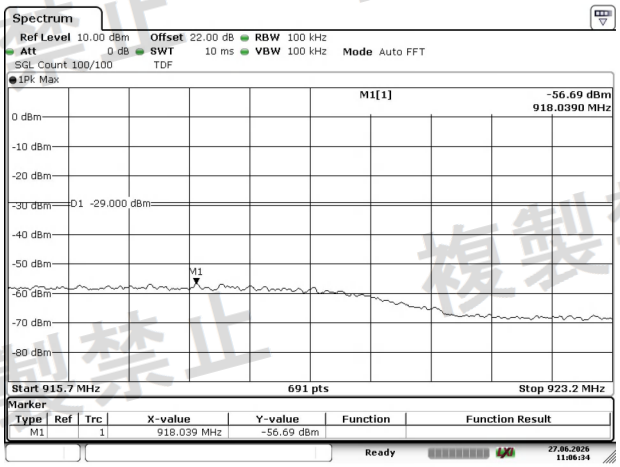




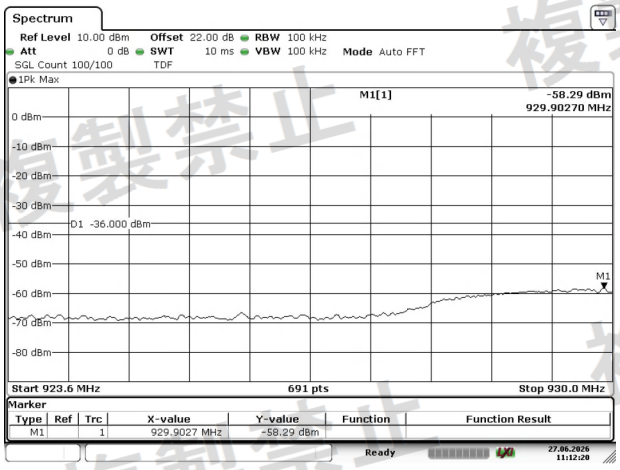
900MHz~915MHz



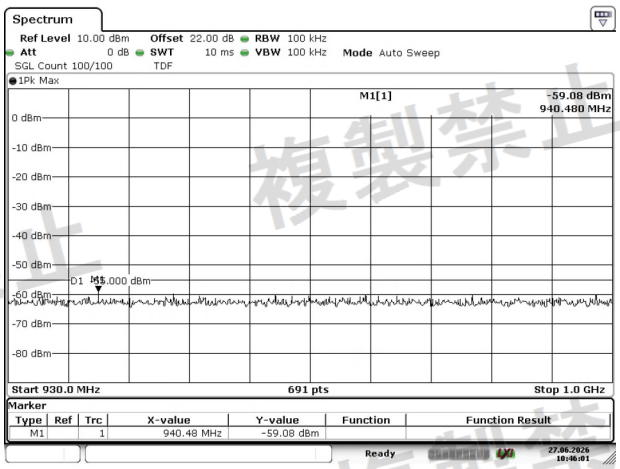
915MHz~915.7MHz



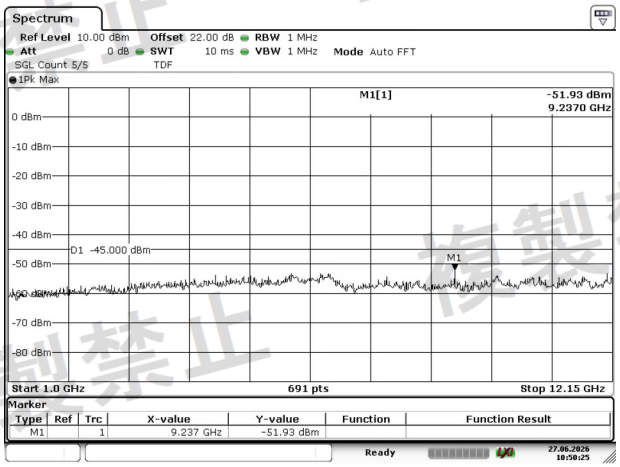
915.7MHz~923.2MHz



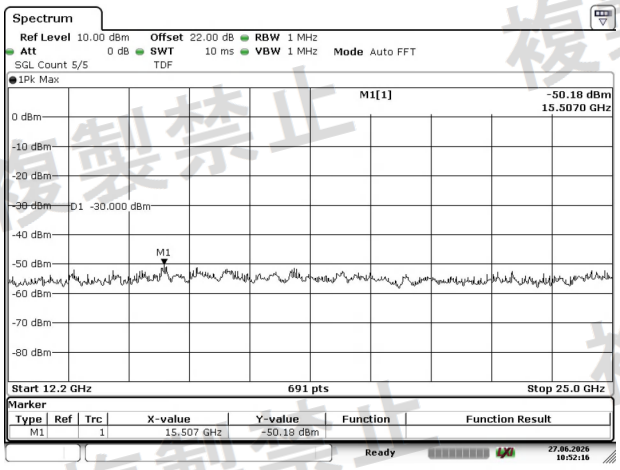
923.6MHz~930MHz



930MHz~1000MHz



1000MHz~12150MHz



12200MHz~25000MHz

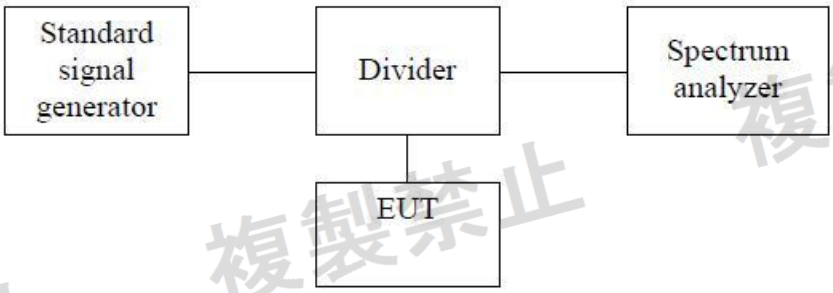
9. Carrier Sensing Function Test

9.1. Test Limit

Test Limit		
Frequency (MHz)	Total transmission time	Carrier Sensing Function *1
916.7～923.5MHz	N/A	Feeder input point: *Antenna power*10mW or less:-64dBm *Antenna power*10 (<) ~ (≤)250mW: -74dBm *Antenna power*more than 250mW: -74dBm-(antenna power XXmW-250mW) Receive bandwidth 200xnkHz Judgement time: 5ms or more

9.2. Test Setup

Measuring systematic diagram

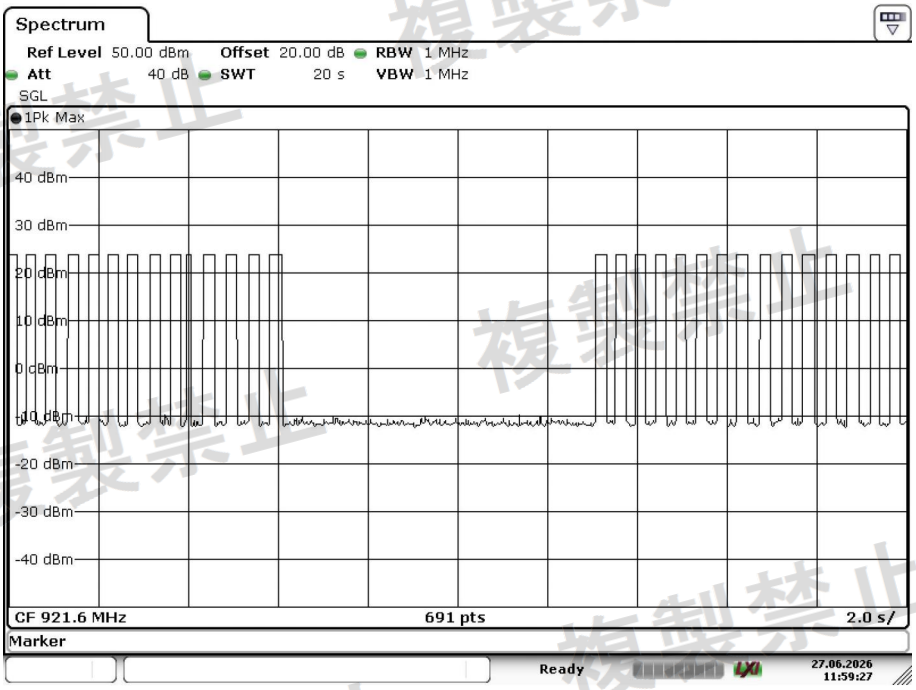


9.3. Test Procedure

1. SSG adjusted the frequency as same as the EUT transmitted signal and emitted the absence of modulation from SSG and power level is -80dBm. Then turn off the RF signal of SSG.
2. EUT have transmitted the maximum modulation signal and fixed channelize.
3. Setting of SA is following as: RB:1MHz / VB:1MHz / SPAN: 0Hz / AT: 40dB /Ref: 50dBm / Sweep time: 20s / Sweep Mode: Continuous sweep / Detect mode: Positive peak.
4. SSG RF Signal On.
5. EUT shall be stop the transmitted any signal and SSG RF Signal Off. Then EUT will be continuous transmitted signal.

9.4. Test Results

Pass

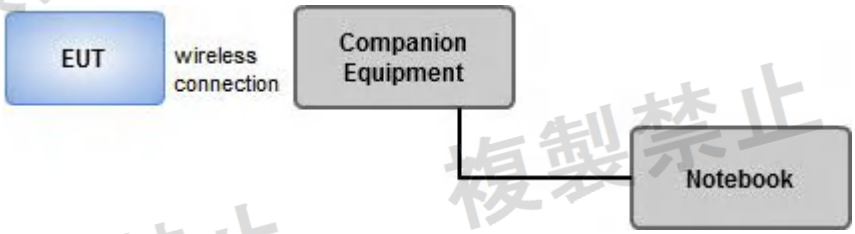


10. Interference Prevention Function Test

10.1. Limit

Requirement:	Chiefly, the one automatically to transmit and to receive identification code with the wireless equipment of the wireless stationused in the same premises.

10.2. Test Setup



10.3. Test Configuration

1. Set EUT under operating mode and link up with companion equipment
2. Check communication status between EUT and companion equipment is normal
3. Confirm the MAC address of EUT

10.4. Test Data

Pass

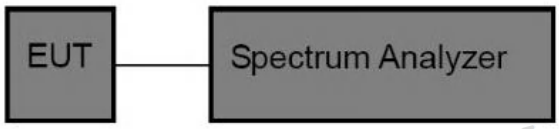
Test Mode	ID Code	Test Results
RFID	6C:E8:16:E7:7B:08	Pass

11. Secondary Radiated Emission Strength Test

11.1. Limit and Reference Bandwidth

Frequency band	Limit on Secondary Radiated Emissions (Antenna input)	Reference bandwidth
f <= 710 MHz	−54 dBm	100 kHz
710 MHz < f <= 900 MHz	−55 dBm	1 MHz
900 MHz < f <= 915 MHz	−55 dBm	100 kHz
915 MHz < f <= 930 MHz	−54 dBm	100 kHz
930 MHz < f <= 1000 MHz	−55 dBm	100 kHz
1000 MHz < f	−47 dBm	1 MHz

11.2. Test Setup



11.3. Test Procedure

Test Frequency: test channel,
RBW: From 900MHz up to 1GHz and if, 100kHz from 30MHz to 710MHz frequency sweep width
From 1GHz to 10GHz and if, 1MHz to 710MHz from 900MHz frequency sweep width
VBW=RBW
Sweep time=Auto, Detector mode=Positive peak

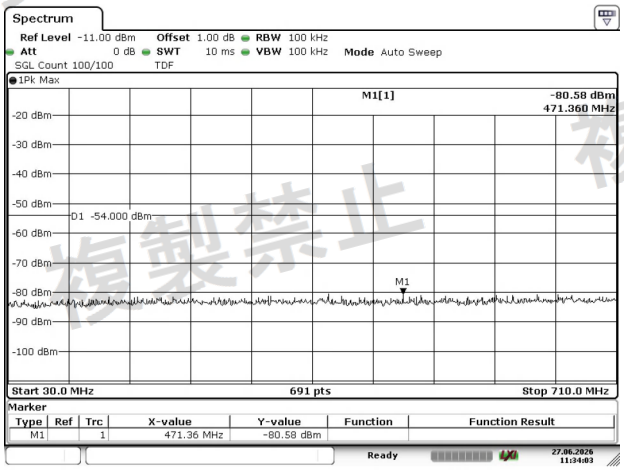
11.4. Test Data

Pass

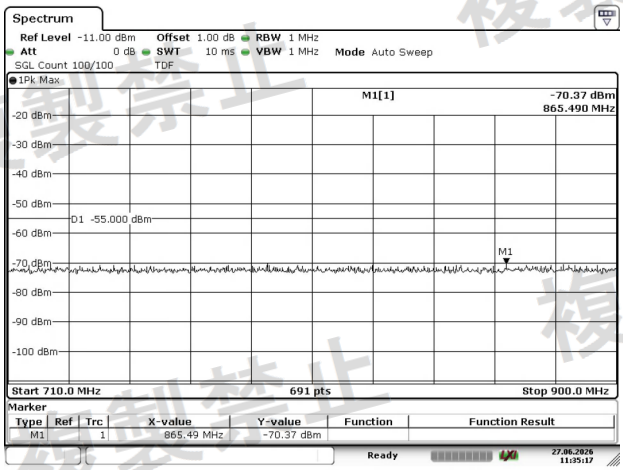
Please refer to the following data.

Test Condition	Freq(MHz)	Freq.Range [MHz]	Freq. [MHz]	Result [dBm]	Limit [dBm]	Verdict
NTNV	916.8	30~710	471.36	-80.58	≤-54	PASS
		710~900	864.49	-70.37	≤-55	PASS
		900~915	911.277	-83.60	≤-55	PASS
		915-930	924.671	-83.79	≤-54	PASS
		930-1000	948.89	-80.79	≤-55	PASS
		1000-12150	6882	-73.95	≤-47	PASS
		12200-25000	18248	-71.86	≤-47	PASS
	921.6	30~710	565.86	-80.04	≤-54	PASS
		710~900	718.66	-69.90	≤-55	PASS
		900~915	900.445	-84.61	≤-55	PASS
		915-930	925.409	-84.00	≤-54	PASS
		930-1000	979.08	-80.55	≤-55	PASS
		1000-12150	6930	-75.25	≤-47	PASS
		12200-25000	16173	-72.81	≤-47	PASS
	923.4	30~710	686.87	-79.96	≤-54	PASS
		710~900	795.93	-69.71	≤-55	PASS
		900~915	905.373	-84.67	≤-55	PASS
		915-930	927.059	-84.27	≤-54	PASS
		930-1000	911.74	-81.21	≤-55	PASS
		1000-12150	6204	-74.58	≤-47	PASS
		12200-25000	24731	-72.46	≤-47	PASS

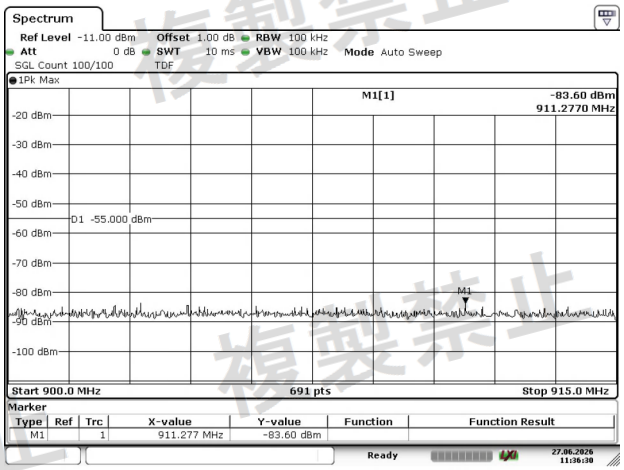
Test Plots of Low Channel



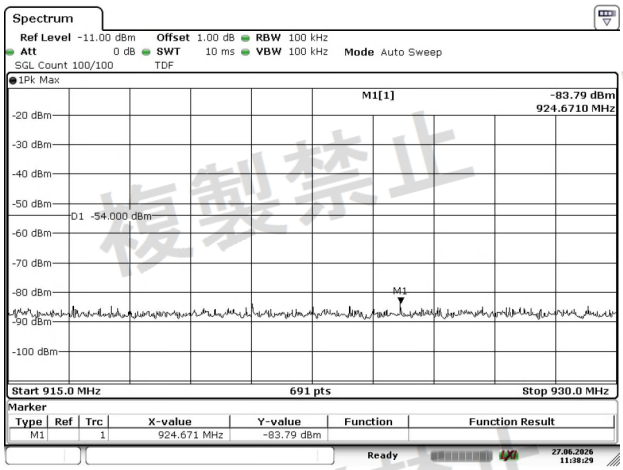
30MHz~710MHz



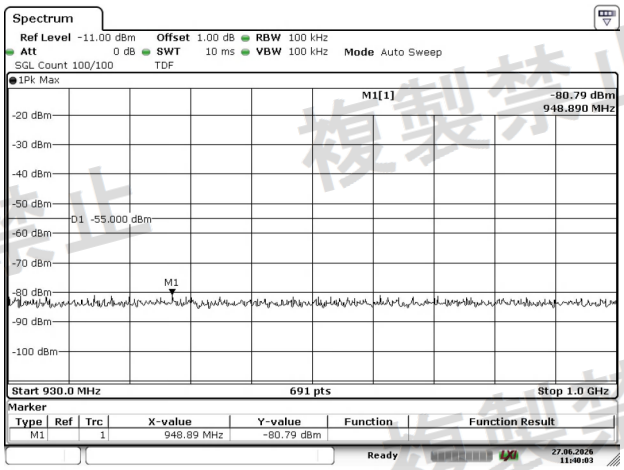
710MHz~900MHz



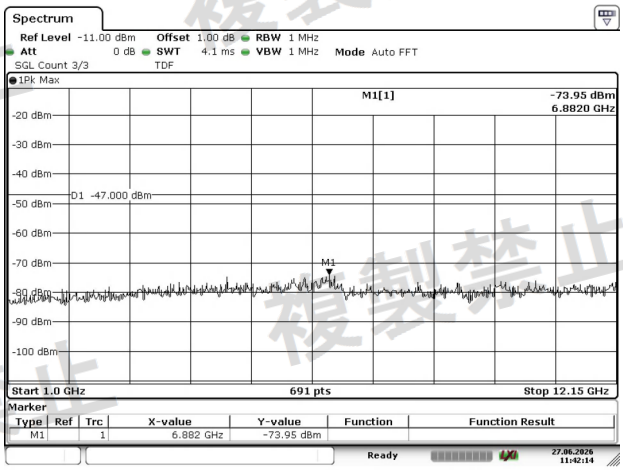
900MHz~915MHz



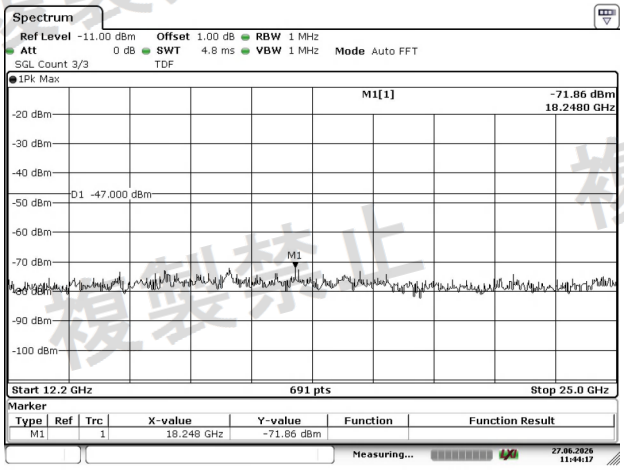
915MHz~930MHz



930MHz~1000MHz

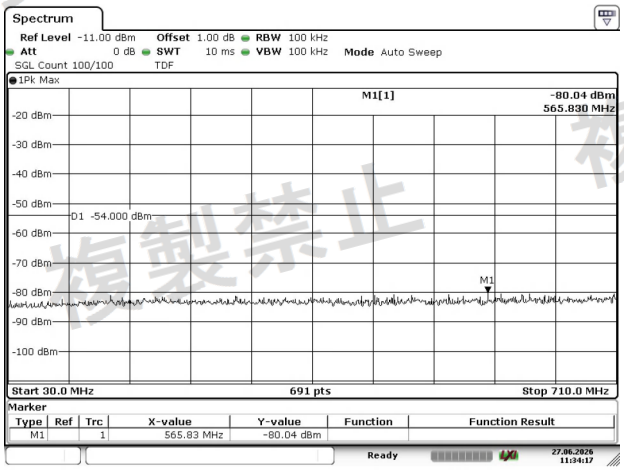


1000MHz~12150MHz

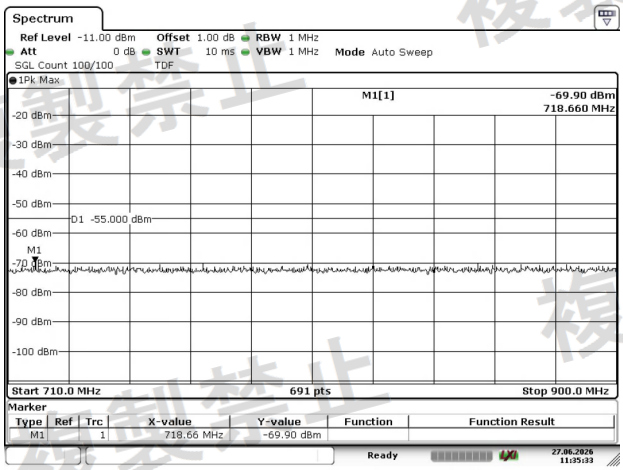


12200MHz~25000MHz

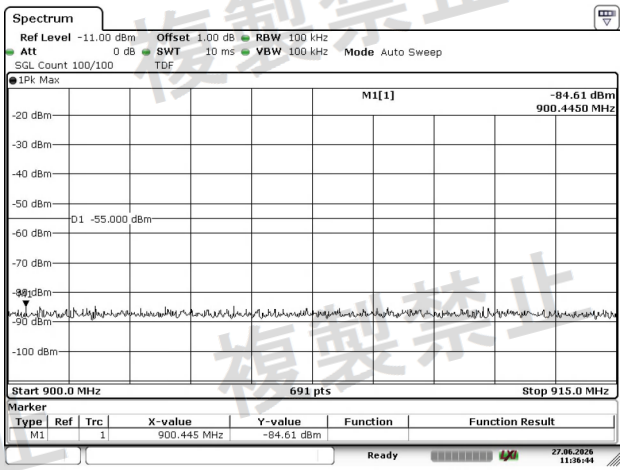
Test Plots of Middle Channel



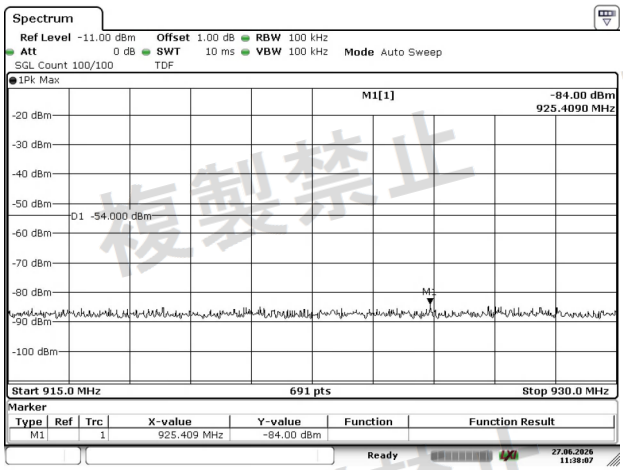
30MHz~710MHz



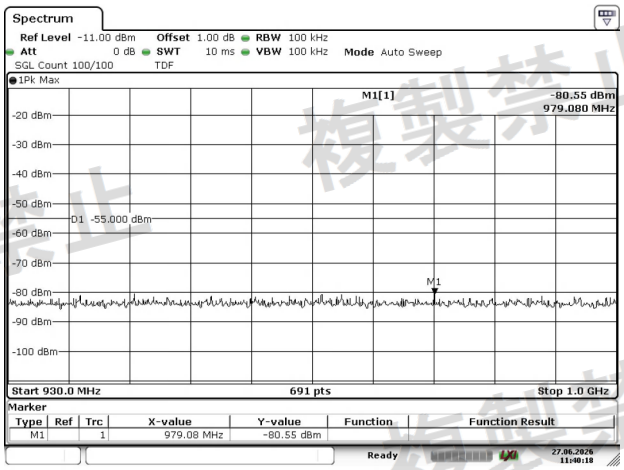
710MHz~900MHz



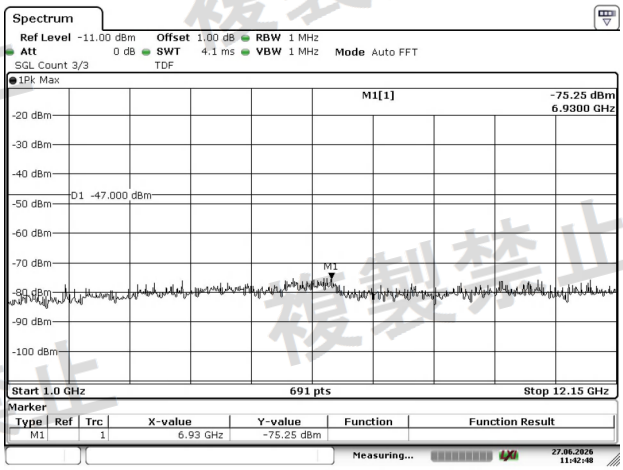
900MHz~915MHz



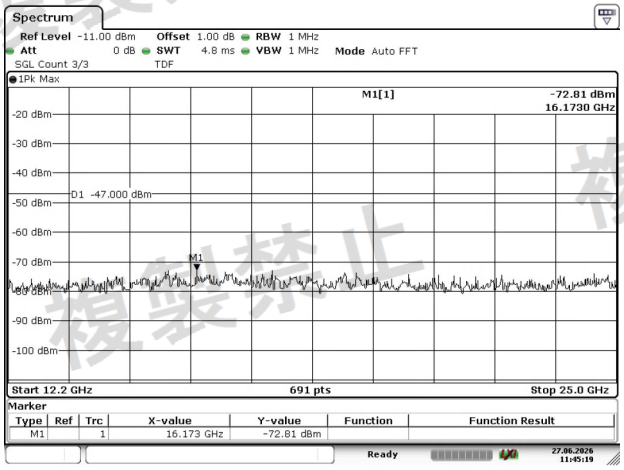
915MHz~930MHz



930MHz~1000MHz

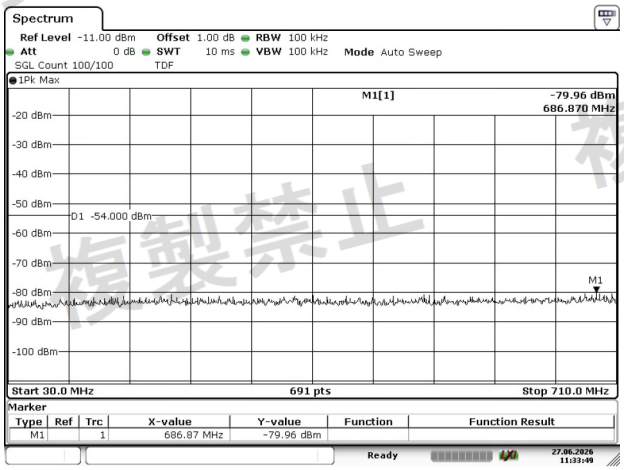


1000MHz~12150MHz

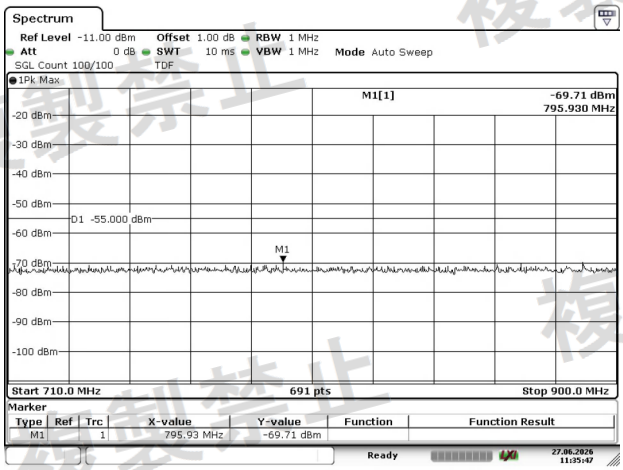


12200MHz~25000MHz

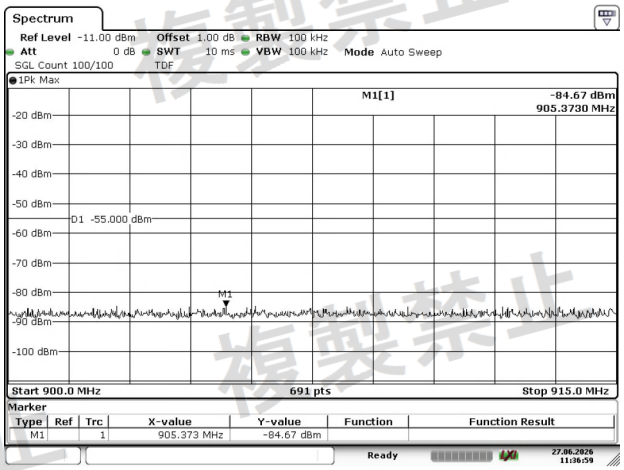
Test Plots of High Channel



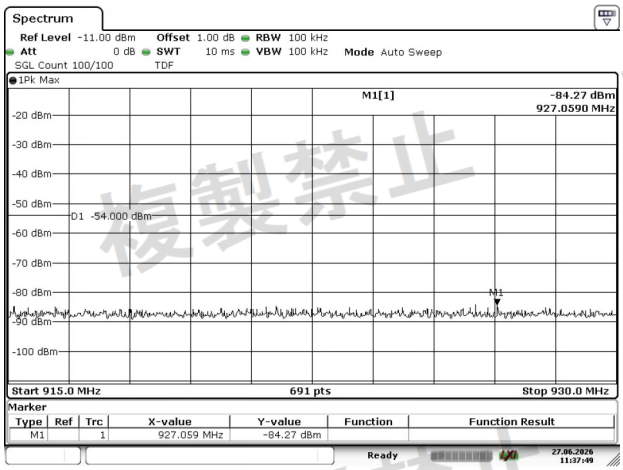
30MHz~710MHz



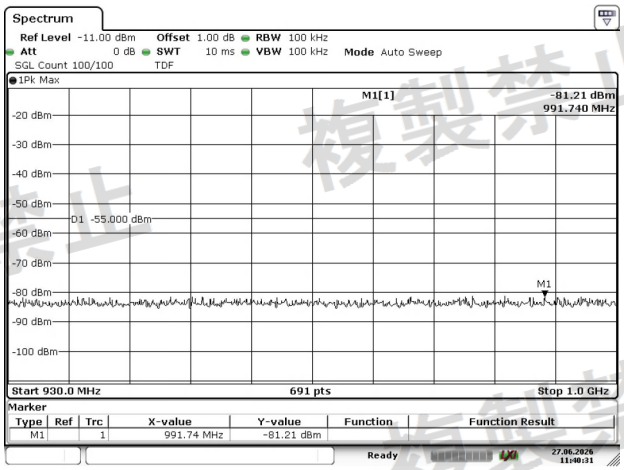
710MHz~900MHz



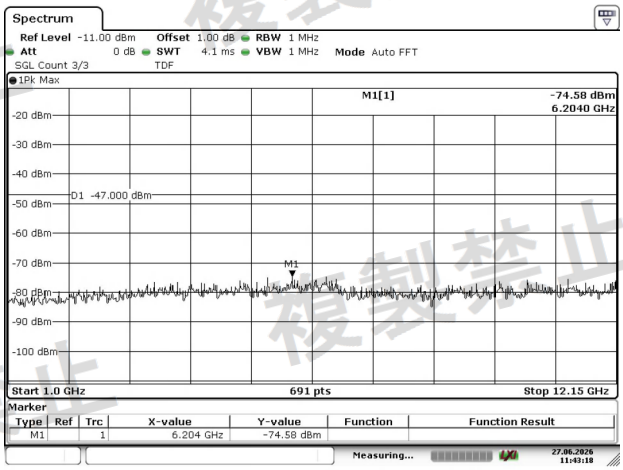
900MHz~915MHz



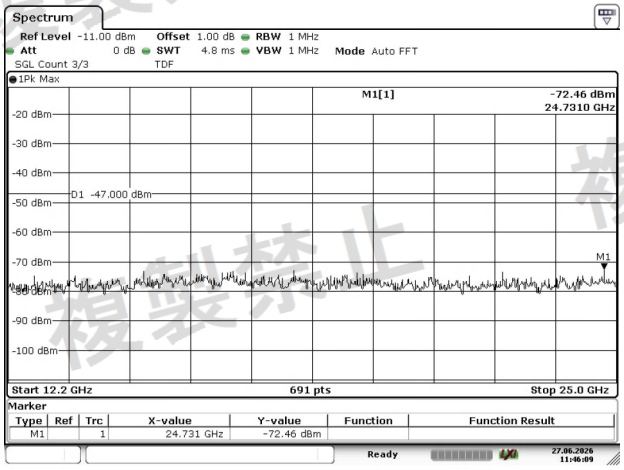
915MHz~930MHz



930MHz~1000MHz



1000MHz~12150MHz



12200MHz~25000MHz

APPENDIX I -- TEST SETUP PHOTOGRAPH

Please refer to separated files Appendix I -- Test Setup Photograph_RF

APPENDIX II -- EXTERNAL PHOTOGRAPH

Please refer to separated files Appendix II -- External Photograph

APPENDIX III -- INTERNAL PHOTOGRAPH

Please refer to separated files Appendix III -- Internal Photograph

---------- End of Report ----------